Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/911,886	OKAUE, TAKUMI
Examiner	Art Unit

Shin-Hon Chen

2131

	SEAR	CHED	
Class	Subclass	Date	Examiner
713	193,170, 181	9/26/2005	S.C.
380	29	9/26/2005	S.C.
713	172, 192	9/26/2005	S.C.
340	825.52	9/26/2005	S.C.

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		9/26/2005	S.C.
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